TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7SET02F, TC7SET02FU

## 2-INPUT NOR GATE

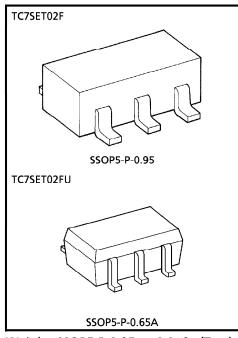
The TC7SET02 is an advanced high speed CMOS 2-INPUT NOR GATE fabricated with silicon gate CMOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The input threshold levels are compatible with TTL output voltage. This device can be used for level converter for interfacing 3V to 5V system.

An input protection circuit ensures that 0V to 7V can be applied to the input pins without regard to the supply voltage.

#### **FEATURES**

- High Speed ...... t<sub>pd</sub> = 5.0ns (Typ.)
   at V<sub>CC</sub> = 5V
- Low Power Dissipation  $\cdots I_{CC} = 2\mu A$  (Max.) at  $Ta = 25^{\circ}C$
- Compatible with TTL outputs ······· V<sub>IL</sub> = 0.8V (Max.)
   V<sub>IH</sub> = 2.0V (Min.)
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays ······· t<sub>pLH</sub> ≒t<sub>pHL</sub>

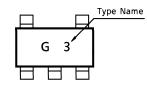


Weight SSOP5-P-0.95 : 0.016g (Typ.) SSOP5-P-0.65A : 0.006g (Typ.)

### MAXIMUM RATINGS (Ta = 25°C)

| CHARACTERISTIC                     | SYMBOL           | RATING                    | UNIT   |
|------------------------------------|------------------|---------------------------|--------|
| Supply Voltage Range               | Vcc              | - 0.5~7.0                 | V      |
| DC Input Voltage                   | V <sub>IN</sub>  | -0.5~7.0                  | \<br>\ |
| DC Output Voltage                  | Vout             | -0.5~V <sub>CC</sub> +0.5 | ٧      |
| Input Diode Current                | ΙΚ               | - 20                      | mA     |
| Output Diode Current               | loк              | ± 20                      | mA     |
| DC Output Current                  | IOUT             | ± 25                      | mA     |
| DC V <sub>CC</sub> /Ground Current | lcc              | ± 50                      | mΑ     |
| Power Dissipation                  | PD               | 200                       | mW     |
| Storage Temperature                | T <sub>stg</sub> | <b>-65∼150</b>            | °C     |
| Lead Temperature (10 s)            | TL               | 260                       | °C     |

#### MARKING



## TRUTH TABLE

| Α | В | Υ |
|---|---|---|
| L | L | Н |
| L | Τ | Ь |
| Н | L | L |
| Н | Н | L |

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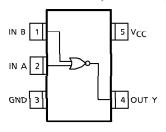
#### **LOGIC DIAGRAM**



### **RECOMMENDED OPERATING CONDITIONS**

| CHARACTERISTIC           | SYMBOL           | RATING         | UNIT |
|--------------------------|------------------|----------------|------|
| Supply Voltage           | Vcc              | 4.5~5.5        | V    |
| Input Voltage            | VIN              | 0~5.5          | V    |
| Output Voltage           | VOUT             | 0~5.5          | V    |
| Operating Temperature    | T <sub>opr</sub> | <b>-</b> 40∼85 | °C   |
| Input Rise and Fall Time | dt / dv          | 0~20           | ns/V |

## PIN ASSIGNMENT (TOP VIEW)



## DC ELECTRICAL CHARACTERISTICS

| CHADACTEDISTIC              | CAMBOI                              | TEST CO                                  | ST CONDITION            |      | Ta = 25°C |       |        | $Ta = -40 \sim 85^{\circ}C$ |       | UNIT    |
|-----------------------------|-------------------------------------|--|-------------------------|------|-----------|-------|--------|-----------------------------|-------|---------|
| CHARACTERISTIC              | HARACTERISTIC SYMBOL TEST CONDITION |  | ۷<br>(ک                 | MIN. | TYP.      | MAX.  | MIN.   | MAX.                        | UNIT  |         |
| High-Level                  | V <sub>IH</sub>                     |  |                         | 4.5~ | 2.0       |       |        | 2.0                         |       | ٧       |
| Input Voltage               | VIH                                 |  |                         | 5.5  | 2.0       |       | _      | 2.0                         |       | V       |
| Low-Level                   | \/                                  |  |                         | 4.5~ |           |       | 0.8    |                             | 0.8   | V       |
| Input Voltage               | VIL                                 |  |                         | 5.5  | _         | -     | 0.8    | _                           | 0.8   | ٧       |
| High-Level                  | \/                                  |  | $I_{OH} = -50 \mu A$    | 4.5  | 4.4       | 4.5   | _      | 4.4                         | _     | V       |
| Output Voltage              | Vон                                 | $V_{IN} = V_{IH}$                        | I <sub>OH</sub> = -8mA  | 4.5  | 3.94      | _     | _      | 3.80                        | _     |         |
| Low-Level                   | V                                   | $V_{IN} = V_{IH}$                        | I <sub>OL</sub> = 50/4A | 4.5  | _         | 0.0   | 0.10   | _                           | 0.10  | V       |
| Output Voltage              | VOL                                 | or V <sub>IL</sub>                       | I <sub>OL</sub> = 8mA   | 4.5  | _         | _     | 0.36   | _                           | 0.44  | v       |
| Input Leakage               | l                                   | \/                                       | CND                     | 0~   |           |       | ± 0.1  |                             | ±10   |         |
| Current                     | l IN                                | V <sub>IN</sub> = 5.5V or GND            |                         | 5.5  | _         | _   _ | ± U. I | _                           | ± 1.0 | μΑ      |
| Quiescent Supply<br>Current | lcc                                 | V <sub>IN</sub> = V <sub>CC</sub> or GND |                         | 5.5  | _         | _     | 2.0    | _                           | 20.0  | $\mu$ A |
|                             | <sup>I</sup> CCT                    | PER INPUT                                | :V <sub>IN</sub> = 3.4V | 5.5  | _         | _     | 1.35   | _                           | 1.50  | mA      |
|                             |                                     | OTHER INPUT:V <sub>CC</sub> or GND       |                         |      |           |       |        |                             |       |         |

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| AC | <b>ELECTRICAL</b> | <b>CHARACTERISTICS</b> | (Input t | $r = t_f = 3ns$ |
|----|-------------------|------------------------|----------|-----------------|
|----|-------------------|------------------------|----------|-----------------|

| CHARACTERISTIC                | SYMBOL          | TEST ( | TEST CONDITION |                     | Ta = 25°C |      |      | Ta = -40~85°C |      | UNIT |
|-------------------------------|-----------------|--------|----------------|---------------------|-----------|------|------|---------------|------|------|
| CHARACTERISTIC                | STIVIDUL        |        | VCC (V)        | C <sub>L</sub> (pF) | MIN.      | TYP. | MAX. | MIN.          | MAX. | UNII |
| Propagation Delay             | tPLH            |        | 5.0 ± 0.5      |                     | _         | 5.0  | 6.9  | 1.0           | 8.0  |      |
| Time                          | tPHL            |        | 3.0 ± 0.3      | 50                  | _         | 5.5  | 7.9  | 1.0           | 9.0  | ns   |
| Input Capacitance             | CIN             |        |                |                     | _         | 4    | 10   | _             | 10   |      |
| Power Dissipation Capacitance | C <sub>PD</sub> | (1)    | Note 1)        |                     | _         | 17   | _    | _             | _    | pF   |

(Note 1): CpD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

ICC (opr) = CpD · VCC · fIN + ICC

## INPUT EQUIVALENT CIRCUIT

